

Notice of References Cited	Application/Control No. 09/617,036	Applicant(s)/Patent Under Reexamination PAIK ET AL.	
	Examiner Michael W. Hoyer	Art Unit 2623	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2006/0105804 A1	05-2006	Kumar, Rajendra	455/550.1
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NON-PATENT DOCUMENTS

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